

Form PTO-1449  
U.S. Application No.: 10/725,933  
Attorney Docket No.: HK9225US  
IDS Filed: January 2, 2008

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

In re application of: Yang et al.

Confirmation No.: 4487

Serial No.: 10/725,933

Group No.: 2891

Filed: December 3, 2003

Examiner: David A. Zarneke

For: FAN OUT TYPE WAFER LEVEL PACKAGE STRUCTURE AND METHOD OF THE SAME

Mail Stop Amendment  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

U.S. Patent Documents

<u>Examiner Initials</u>	<u>Document Number</u>	<u>Date</u>	<u>Name</u>	<u>Class</u>
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Other Documents (Inc. Author, Title, Date, Pertinent Pages, Etc.)

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_____	Invar From Wikipedia, the free encyclopedia, <a href="http://en.wikipedia.org/wiki/Invar">http://en.wikipedia.org/wiki/Invar</a> 2 pages, last accessed 02/18/2007.

Examiner:

Date Considered:

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\*\*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.